

# AO4918



Units

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# Asymmetric Dual N-Channel Enhancement Mode Field Effect Transistor

## **General Description**

The AO4918 uses advanced trench technology to provide excellent R<sub>DS(ON)</sub> and low gate charge. The two MOSFETs make a compact and efficient switch and synchronous rectifier combination for use in DC-DC converters. A Schottky diode is co-packaged in parallel with the synchronous MOSFET to boost efficiency further Standard Product AO4918 is Pb-free (meets ROHS & Sony 259 specifications). AO4918L is a Green Product ordering option. AO4918 and AO4918L are electrically identical.

## **Features**

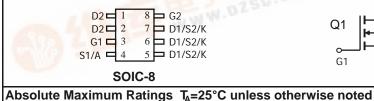
Q1

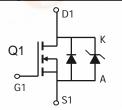
Q2

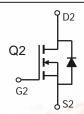
$$\begin{split} &V_{DS}\left(V\right) = 30V & V_{DS}(V) = 30V \\ &I_{D} = 9.3A \; (V_{GS} = 10V) & I_{D} = 8.3A \; (V_{GS} = 10V) \\ &R_{DS(ON)} < 14.5 m\Omega & <18 m\Omega \; (V_{GS} = 10V) \\ &R_{DS(ON)} < 16 m\Omega & <27 m\Omega \; (V_{GS} = 4.5V) \end{split}$$

### **SCHOTTKY**

 $V_{DS}(V) = 30V, I_F = 3A, V_F < 0.5V@1A$ 







Parameter		Symbol	Max Q1	Max Q2
Drain-Source Voltage	9	V <sub>DS</sub>	30	30
Gate-Source Voltage	-17	$V_{GS}$	±12	±20
Continuous Drain	T <sub>A</sub> =25°C	Ago	9.3	8.3
Current A	T <sub>A</sub> =70°C	I <sub>D</sub>	7.4	6.7
Dula a I Duais Ourses	В	1	4.0	4.0

Current A	T <sub>A</sub> =70°C	$I_D$	7.4	6.7	Α
Pulsed Drain Current <sup>B</sup>		$I_{DM}$	40	40	
392 -	T <sub>A</sub> =25°C	D.	2	2	W
Power Dissipation	T <sub>A</sub> =70°C	]'D	1.28	1.28	, vv
Junction and Storage	Temperature Range	$T_J$ , $T_{STG}$	-55 to 150	-55 to 150	°C

Parameter		Symbol	Maximum Schottky	Units
Reverse Voltage		V <sub>DS</sub>	30	V
Continuous Forward	T <sub>A</sub> =25°C		3	
Current <sup>A</sup>	T <sub>A</sub> =70°C	l <sub>F</sub>	2.2	Α
Pulsed Diode Forward	d Current <sup>B</sup>	I <sub>FM</sub>	20	
AGD Z.FE	T <sub>A</sub> =25°C	D	2	W
Power Dissipation <sup>A</sup>	T <sub>A</sub> =70°C	T <sub>D</sub>	1.28	VV
Junction and Storage	Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C

#### AO4918

Parameter: Thermal Characteris	tics MOSFET Q1	Symbol	Тур	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s	$R_{\theta JA}$	53	62.5	
Maximum Junction-to-Ambient A	Steady-State	N <sub>θ</sub> JA	81.9	110	°C/W
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{\theta JL}$	30.5	40	
Parameter: Thermal Characteris	tics MOSFET Q2	Symbol	Тур	Max	Units
Maximum Junction-to-Ambient A	t ≤ 10s	$ R_{\theta JA}$	53	62.5	
Maximum Junction-to-Ambient A	Steady-State	Γ <sub>θ</sub> JA	81.9	110	°C/W
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{\theta JL}$	30.5	40	

Thermal Characteristics Schottky							
Maximum Junction-to-Ambient A	t ≤ 10s	D	50.4	62.5			
Maximum Junction-to-Ambient <sup>A</sup>	Steady-State	$\kappa_{\theta JA}$	86	110	°C/W		
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{\theta JL}$	26.6	40			

- A: The value of R  $_{\theta,JA}$  is measured with the device mounted on 1in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T  $_A$ =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t  $_{\perp}$  ≤ 10s thermal resistance rating.
- B: Repetitive rating, pulse width limited by junction temperature.
- C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R  $_{\theta JL}$  and lead to ambient.
- D. The static characteristics in Figures 1 to 6 are obtained using 80  $\mu$ s pulses, duty cycle 0.5% max.
- E. These tests are performed with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T  $_A$ =25°C. The SOA curve provides a single pulse rating.
- F. The Schottky appears in parallel with the MOSFET body diode, even though it is a separate chip. Therefore, we provide the net forward drop, capacitance and recovery characteristics of the MOSFET and Schottky. However, the thermal resistance is specified for each chip separately.

Rev4: August 2005

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#### Q1 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
	7 0 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	V <sub>R</sub> =30V		0.007	0.05	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current. (Set by Schottky leakage)	V <sub>R</sub> =30V, T <sub>J</sub> =125°C		3.2	10	mA
	(Oct by Ochotiky leakage)	V <sub>R</sub> =30V, T <sub>J</sub> =150°C		12	20	
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±12V			100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	0.6	1.1	2	V
$I_{D(ON)}$	On state drain current	$V_{GS}$ =4.5V, $V_{DS}$ =5V	40			Α
		V <sub>GS</sub> =10V, I <sub>D</sub> =9.3A		11.7	14.5	mΩ
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	T <sub>J</sub> =125°C		15.4	19	1115.2
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =8.8A		13.1	16	mΩ
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_{D}$ =9.3A	30	37		S
$V_{SD}$	Diode+Schottky Forward Voltage	I <sub>S</sub> =1A		0.46	0.5	V
Is	Maximum Body-Diode+Schottky Continuous Current				3.5	Α
DYNAMIC	PARAMETERS					
C <sub>iss</sub>	Input Capacitance			3740	4488	pF
Coss	Output Capacitance (FET + Schottky)	$V_{GS}$ =0V, $V_{DS}$ =15V, f=1MHz		295		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			186		pF
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz		0.86	1.1	Ω
SWITCHI	NG PARAMETERS					
$Q_g$	Total Gate Charge			30.5	37	nC
$Q_{gs}$	Gate Source Charge	$V_{GS}$ =4.5V, $V_{DS}$ =15V, $I_{D}$ =9.3A		4.5		nC
$Q_{gd}$	Gate Drain Charge			8.5		nC
$t_{D(on)}$	Turn-On DelayTime			6	9	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_L$ =1.6 $\Omega$ ,		8.2	12	ns
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}$ =3 $\Omega$		54.5	75	ns
t <sub>f</sub>	Turn-Off Fall Time			10.5	15	ns
t <sub>rr</sub>	Body Diode + Schottky Reverse Recovery Time	I <sub>F</sub> =9.3A, dI/dt=100A/μs		23.5	28	ns
Q <sub>rr</sub>	Body Diode + Schottky Reverse Recovery Charge	I <sub>F</sub> =9.3A, dI/dt=100A/μs		13.3	16	nC

A: The value of R <sub>BJA</sub> is measured with the device mounted on 1 in <sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.

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B: Repetitive rating, pulse width limited by junction temperature.

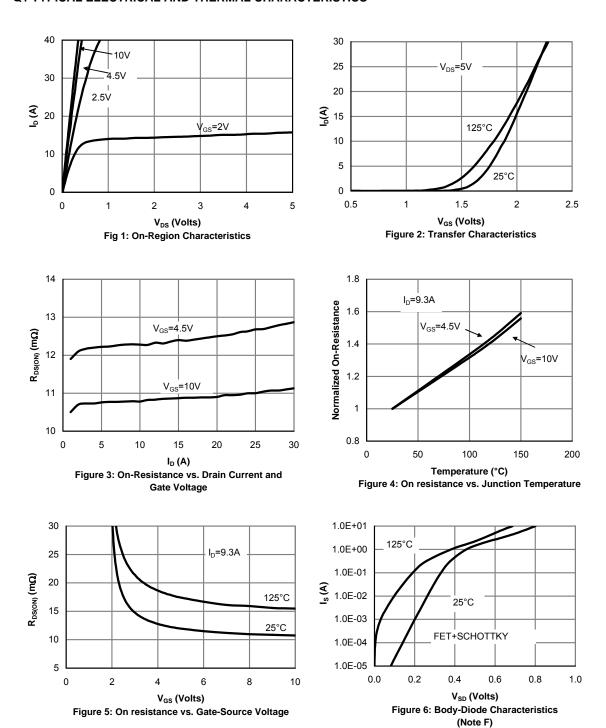
C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R  $_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80  $\mu s$  pulses, duty cycle 0.5% max.

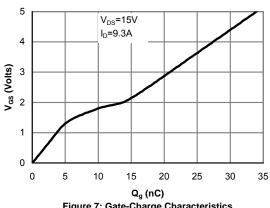
E. These tests are performed with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25°C. The SOA curve provides a single pulse rating.

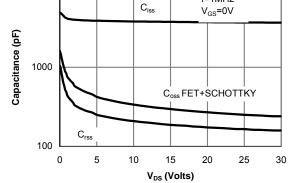
F. The Schottky appears in parallel with the MOSFET body diode, even though it is a separate chip. Therefore, we provide the net forward drop, capacitance and recovery characteristics of the MOSFET and Schottky. However, the thermal resistance is specified for each chip separately Rev4: August 2005.

### Q1 TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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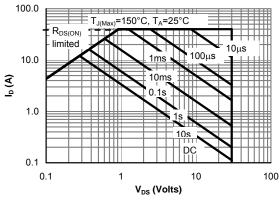


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Figure 7: Gate-Charge Characteristics

Figure 8: Capacitance Characteristics

f=1MHz



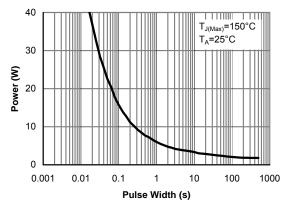


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

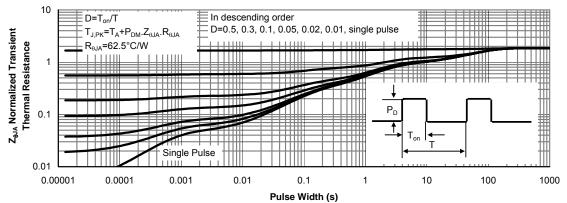


Figure 11: Normalized Maximum Transient Thermal Impedance

#### AO4918

## Q2 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units			
STATIC F	STATIC PARAMETERS								
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V			
ı	Zero Gate Voltage Drain Current	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V		0.004	1	^			
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	T <sub>J</sub> =55°C			5	μΑ			
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V			100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_D=250\mu A$	1	1.8	3	V			
$I_{D(ON)}$	On state drain current	$V_{GS}$ =4.5V, $V_{DS}$ =5V	30			Α			
		V <sub>GS</sub> =10V, I <sub>D</sub> =8.3A		14.9	18	mΩ			
$R_{DS(ON)}$	Static Drain-Source On-Resistance	T <sub>J</sub> =125°C		22	27	1112.2			
		$V_{GS}$ =4.5V, $I_D$ =7A		21.6	27	mΩ			
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_D$ =8.3A		23		S			
$V_{SD}$	Diode+Schottky Forward Voltage	I <sub>S</sub> =1A		0.45	0.5	V			
$I_S$	Maximum Body-Diode+Schottky Continuous Current				3	Α			
DYNAMIC	CPARAMETERS								
C <sub>iss</sub>	Input Capacitance			1040	1250	pF			
C <sub>oss</sub>	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =15V, f=1MHz		180		pF			
C <sub>rss</sub>	Reverse Transfer Capacitance			110		pF			
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz		0.7	0.85	Ω			
SWITCHI	NG PARAMETERS								
$Q_g(10V)$	Total Gate Charge			19.2	24	nC			
$Q_g$	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =8.3A		9.36	12	nC			
$Q_{gs}$	Gate Source Charge	V GS - 10 V, V DS - 10 V, ID - 0.0A		2.6		nC			
$Q_{gd}$	Gate Drain Charge			4.2		nC			
t <sub>D(on)</sub>	Turn-On DelayTime			5.2	7.5	ns			
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_{L}$ =1.8 $\Omega$ ,		4.4	6.5	ns			
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}$ =3 $\Omega$		17.3	25	ns			
t <sub>f</sub>	Turn-Off Fall Time			3.3	5	ns			
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =8.5A, dI/dt=100A/μs		16.7	21	ns			
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =8.5A, dI/dt=100A/μs		6.7	10	nC			

A: The value of  $R_{\text{BJA}}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t≤ 10s thermal resistance rating.

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C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R $_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80 µs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25 °C. The SOA curve provides a single pulse rating.

# Q2 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

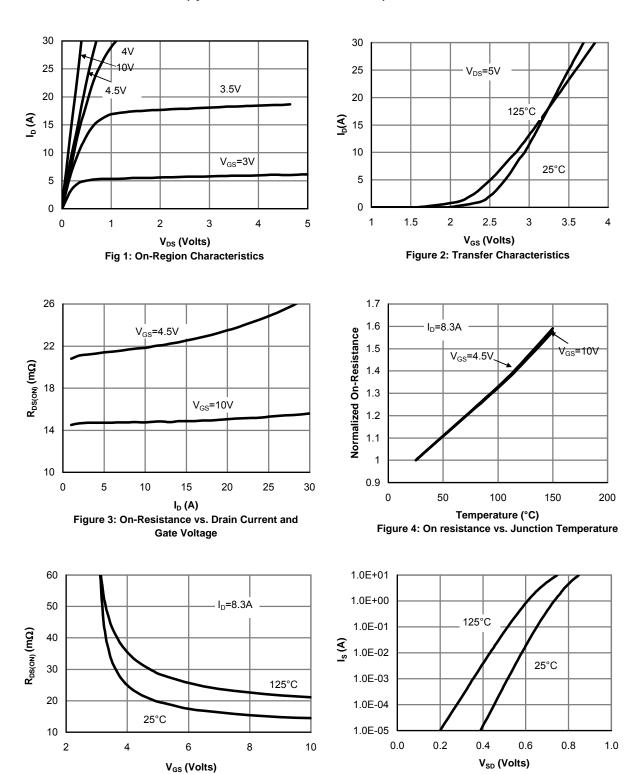


Figure 6: Body-Diode Characteristics

Figure 5: On resistance vs. Gate-Source Voltage

### Q2 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

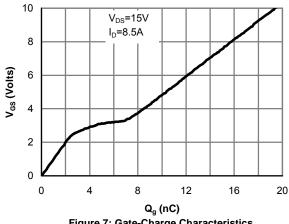


Figure 7: Gate-Charge Characteristics

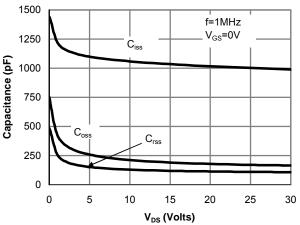


Figure 8: Capacitance Characteristics

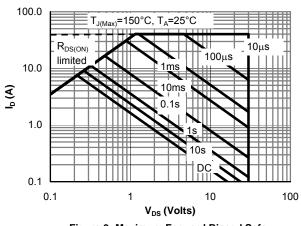


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

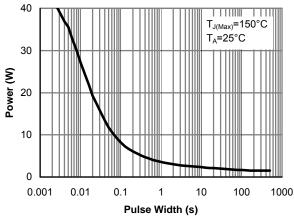


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

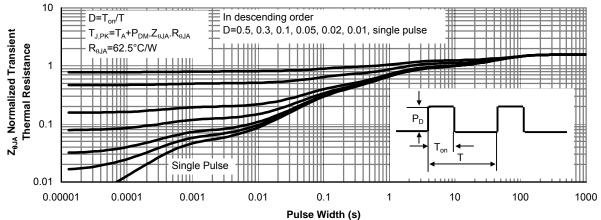


Figure 11: Normalized Maximum Transient Thermal Impedance



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